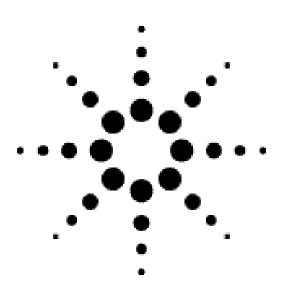


54720D

Data Sheet



Product Specifications

Time-Interval Measurement Accuracy Specifications

Real Time ±[(0.2)(sample interval) + 0.007%
 of delta-time marker reading]

Equivalent Time $\pm (30 \text{ ps} + 0.007\% \text{ of delta-time marker reading})$ (16 averages)
Typical Channel Characteristics
ADC Input Sources
(simultaneous 4 plug-in slots, each having its own 2-GSa/s acquisition) ADC. Acquisition memory is 65,536 points per slot.

Best Accuracy Calibration

Performing the best accuracy cal on a channel just prior to a series of critical measurements will ensure the most accurate results. This cal adjusts the channel s gain, offset, and linearity, and requires a specific plug-in to stay installed in a specific mainframe slot.

Channel Skew Adjustment

The time skew between channels can be manually eliminated all the way to the probe tip to 1-ps resolution.

Probe Calibration A probe calibration routine automatically computes the offset and attenuation created by the probe attached to the channel input. Typical Time Base Characteristics
Time Base Scale (fullscreen is 10 divisions)
100 ps/div to 20 s/div
(in 1-2-5 or fine steps)

Time Base Position Range (auto sample rate and record length)

Pretrigger: 0 to 10 s or one fullscreen width, whichever is larger.

Posttrigger: 0 to 10 s or one fullscreen width, whichever is larger.

Trigger Interpolator Resolution: 1 ps

Time Base Window

Scale: 1 ps/div to the main time base scale



factor

Position: The window must always stay in the time window defined by the main sweep. Typical Triggering Characteristics

Sources

All four input plug-in slots can be used for triggering. See plug-in specifications for more details.

Edge Slope Positive/negative

Holdoff Range 60 ns to 320 ms

Pattern Trigger A pattern can be specified using any channel or external trigger input (up to four bits wide). Each of the inputs can be specified as high, low, or don t care with respect to the trigger level setting for that source. Trigger occurs when that pattern is entered or exited.

Glitch Trigger This mode makes it easy to look for glitches greater than or less than specified width on a single source. You can distinguish glitches down to 3 ns ±1 ns in width and can capture glitches as narrow as 500 ps in width.

Time-Qualified A trigger will occur on the first edge to exit
Pattern Trigger a pattern only if it meets one of these 3
 criteria: 1) pattern present <[time]
 2) pattern present >[time]
 3) pattern present in range
 >[time1] and <[time2].</pre>

The time settings are adjustable from 20 ns to 160 ms $[\pm(3\% + 2 \text{ ns})]$ with 10 ns resolution. Filter recovery time is <=12 ns.

State Trigger A pattern is specified on any three of the four inputs, with the fourth input used as a clock. Trigger occurs on the rising or falling edge of the input specified as the clock, and when the pattern is present or is not present. Setup time for the pattern with respect to the clock is 10 ns or less; hold time is zero.

TV Trigger Standard TV systems: 525 lines 60 Hz 625 lines 50 Hz 875 lines 60 Hz User defined

Event-Delayed Trigger The trigger is qualified by an edge. The delay can be specified as a number of occurrences of a rising or falling edge of any of the inputs. After the delay, an occurrence of a rising or falling edge of any of the inputs will generate the trigger. The trigger occurrence value is selectable from 1 to 16,000,000. The maximum edge counting rate is 70 MHz. Edges occurring <30 ns after the qualifying edge may not be detected.

Time-Delayed Trigger The trigger is qualified by an edge. The



delay is selectable from 30 ns to 160 ms. After the delay, an occurrence of a rising or falling edge on any one selected input will generate the trigger. Functions and Measurements Functions Magnify Invert Add Subtract Multiply Divide Versus Integrate Differentiate Min Max FFT (mag) Histograms Measurement limit testing Waveform mask testing Color graded display Measurements V(ampltd) V(base) V(top) Preshoot Overshoot V p-p V(time) V(min) V(max) V(rms) V(avg) V(upper) V(middle) V(lower) FFT(freq) FFT(mag) FFT(deltafreq) FFT(deltamag) Duty cycle Delta time Period Frequency T(fall) T(rise) T(max) T(min) T(volt) + width - width Histograms p-p median mean std dev u ± 1 sigma u ± 2 sigma u ± 3 sigma hits peak Autoscale Can find repetitive signals: > 50 Hz < 1/2 max sample rate duty cycle > 1 % amplitude> 50 mV p-p (HP 54722A > 150 mV p-p)Display Update and HPIB Throughput Maximum Display Update Rate: 550 Kpixels/s typical Maximum HP-IB Transfer Rate: 500 Kbytes/s typical Throughput Waveforms/second Measurements/second ______ Measurement Vpp Period ______ Front Panel Capture > 170 > 44 > 39 and Transfer Rate HP-IB Capture and > 50 > 33 > 31Transfer Rate ______ This throughput data was taken in the real-time sampling mode (250 MSa/s) with 512-point records on screen, no measurements, no interpolation, fast draw mode, infinite persistence, markers off, math off, and one channel acquisition. Vpp does not require threshold detection, but Period does. Effective Bits Effective Bits 1 MHz 10 MHz 100 MHz 250 MHz 500 MHz 1 GHz (HP 54721A System) Real Time (4 GSa/s) with fs/4 filter interpolation 7.5 7.5 7.2 6.7 6.7 6.2 without fs/4 filter



interpolation 7.0 7.0 6.6 6.1 5.9 5.3

Digital Bandwidth
Limit (fs/20 FIR 8.0 7.9 8.2 7.8 - - Filter)

Typical effective bits of resolution describes the dynamic performance of an ADC sine wave curve fit test. The inputs used are 90% of full scale amplitude sine waves.

FFT

Update rate for 1024 point record is 70 ms. Magnitude accuracy 0.26 db (3%) near dc to -3 db at max bandwidth. Environmental Characteristics Temperature Operating +10° C to +40° C Nonoperating -40° C to +70° C

Humidity Operating Up to 95% relative humidity (noncondensing) at +40° C Nonoperating Up to 90% relative humidity at +65° C

Altitude Operating Up to 4,600 meters (15,000 feet) Nonoperating Up to 15,300 meters (50,000 feet)

Voltage 90 to 132 or 198 to 264 VAC, 48 to 66 Hz

Power 1200 VA; 650 W

Weight Net 26.4 kg (58 lbs) Shipping 33.6 kg (74 lbs)

